Search Notes -

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/820,721	LIAO ET AL.	
Examiner	Art Unit	
Ricardo Pizarro	2661	

	SEARCHED					
Class	Subclass	Date	Examiner			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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EAST	9/12	M
BAST	9/14	W?
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